Notice of References Cited Application/Control No. 10/625,442 Examiner A Elamin Applicant(s)/Patent Under Reexamination KAUSHIK ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| | Α | US-6,931,557 B2 | 08-2005 | Togawa, Yoshifusa | 713/323 |
| | В | US-6,901,521 B2 | 05-2005 | Chauvel et al. | 713/300 |
| | С | US-6,883,104 B2 | 04-2005 | Rosch, Winn L | 713/322 |
| | D | US-6,871,219 B2 | 03-2005 | Noordergraaf et al. | 709/214 |
| | Ε | US-6,859,886 B1 | 02-2005 | Johnson, Stephen B. | 713/600 |
| | F | US-6,836,849 B2 | 12-2004 | Brock et al. | 713/310 |
| | G | US-6,829,713 B2 | 12-2004 | Cooper et al. | 713/320 |
| | Н | US-6,788,156 B2 | 09-2004 | Tam et al. | 331/49 |
| | ı | US-6,574,739 B1 | 06-2003 | Kung et al. | 713/322 |
| | J | US-6,470,456 B1 | 10-2002 | Chung-Chih, Tung | 713/322 |
| | κ | US-6,460,122 B1 | 10-2002 | Otterness et al. | 711/154 |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | . Name | Classification |
|---|---|--|-----------------|---------|---------------------------------------|----------------|
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NON-PATENT DOCUMENTS

| | TOTAL TOTAL DOGUMENTO | | | | | | | |
|---|-----------------------|---|--|--|--|--|--|--|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | | | |
| | U | | | | | | | |
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.